Se	arch Note	es

Application/Control No.	Applicant(s)/Patent under Reexamination
10/615,746	HAAS, JAMES LYNN
Examiner	Art Unit
Sam Chuan C. Yao	1733

	SEARCHED			
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEAR (INCLUDING S	CH NOT)
		DATE	EXMR
updated search		10/11/2005	SCY
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